

**SN55451B THRU SN55454B  
SN75451B THRU SN75454B  
DUAL PERIPHERAL DRIVERS**

D2217, DECEMBER 1976—REVISED MAY 1990

**PERIPHERAL DRIVERS FOR  
HIGH-CURRENT SWITCHING  
AT VERY HIGH SPEEDS**

- Characterized for Use to 300 mA
- High-Voltage Outputs
- No Output Latch-Up at 20 V (After Conducting 300 mA)
- High-Speed Switching
- Circuit Flexibility for Varied Applications
- TTL-Compatible Diode-Clamped Inputs
- Standard Supply Voltages
- Plastic DIP (P) with Copper Lead Frame Provides Cooler Operation and Improved Reliability
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

**SUMMARY OF SERIES 55451B/75451B**

DEVICE	LOGIC OF COMPLETE CIRCUIT	PACKAGES
SN55451B	AND <sup>†</sup>	FK,JG
SN55452B	NAND	FK,JG
SN55453B	OR	FK,JG
SN55454B	NOR	FK,JG
SN75451B	AND	D,P
SN75452B	NAND	D,P
SN75453B	OR	D,P
SN75454B	NOR	D,P

<sup>†</sup>With output transistor base connected externally to output of gate.

**description**

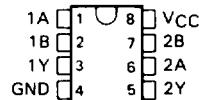
Series SN55451B/75451B dual peripheral drivers are a family of versatile devices designed for use in systems that employ TTL logic. This family is functionally interchangeable with and replaces the SN75450 family and the SN75450A family devices manufactured previously. The speed of the SN55451B/SN75451B family is equal to that of the SN75450 family, and the parts are designed to ensure freedom from latch-up. Diode-clamped inputs simplify circuit design. Typical applications include high-speed logic buffers, power drivers, relay drivers, lamp drivers, MOS drivers, line drivers, and memory drivers.

The SN55451B/SN75451B, SN55452B/SN75452B, SN55453B/SN75453B, and SN55454B/SN75454B are dual peripheral AND, NAND, OR, and NOR drivers, respectively, (assuming positive logic), with the output of the logic gates internally connected to the bases of the n-p-n output transistors.

Series SN55451B drivers are characterized for operation over the full military range of -55°C to 125°C. Series SN75451B drivers are characterized for operation from 0°C to 70°C.

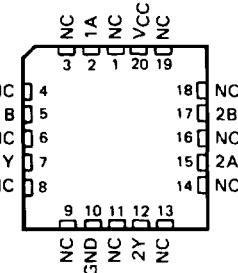
**SN55451B, SN55452B,  
SN55453B, SN55454B . . . JG PACKAGE  
SN75451B, SN75452B,  
SN75453B, SN75454B . . . D OR P PACKAGE**

(TOP VIEW)



**SN55451B, SN55452B,  
SN55453B, SN55454B . . . FK PACKAGE**

(TOP VIEW)



NC—No internal connection

**PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.**

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**SN55451B THRU SN55454B,  
SN75451B THRU SN75454B  
DUAL PERIPHERAL DRIVERS**

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

	SN55451B	SN75451B	UNIT
	SN55452B	SN75452B	
	SN55453B	SN75453B	
	SN55454B	SN75454B	
Supply voltage, V <sub>CC</sub> (see Note 1)	7	7	V
Input voltage	5.5	5.5	V
Interemitter voltage (see Note 2)	5.5	5.5	V
Off-state output voltage	30	30	V
Continuous collector or output current (see Note 4)	400	400	mA
Peak collector or output current (t <sub>w</sub> ≤ 10 ms, duty cycle ≤ 50%, see Note 4)	500	500	mA
Continuous total power dissipation	See Dissipation Rating Table		
Operating free-air temperature range, T <sub>A</sub>	-55 to 125	0 to 70	°C
Storage temperature range	-65 to 150	-65 to 150	°C
Case temperature for 60 seconds	FK package	260	°C
Lead temperature 1.6 mm (1/16 inch) from case for 60 seconds	JG package	300	°C
Lead temperature 1.6 mm (1.16 inch) from case for 10 seconds	D or P package	260	°C

- NOTES: 1. Voltage values are with respect to the network ground terminal unless otherwise specified.  
 2. This is the voltage between two emitters of a multiple-emitter transistor.  
 3. This value applies when the base-emitter resistance (R<sub>BE</sub>) is equal to or less than 500 Ω.  
 4. Both halves of these dual circuits may conduct rated current simultaneously; however, power dissipation averaged over a short time interval must fall within the continuous dissipation rating.

DISSIPATION RATING TABLE

PACKAGE	T <sub>A</sub> ≤ 25°C	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C	T <sub>A</sub> = 125°C
	POWER RATING		POWER RATING	POWER RATING
D	725 mW	5.8 mW/°C	464 mW	—
FK	1375 mW	11.0 mW/°C	880 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	—

**recommended operating conditions**

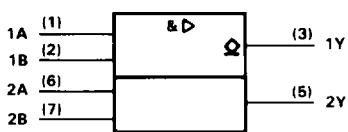
	SERIES 55451B			SERIES 75451B			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V <sub>CC</sub>	4.5	5	5.5	4.75	5	5.25	V
High-level input voltage, V <sub>IH</sub>	2			2			V
Low-level input voltage, V <sub>IL</sub>				0.8		0.8	V
Operating free-air temperature, T <sub>A</sub>	-55	125	0	0	70	°C	



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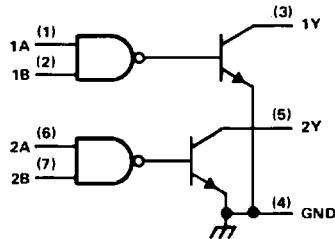
**SN55451B, SN75451B**  
**DUAL PERIPHERAL POSITIVE-AND DRIVERS**

**logic symbol†**



†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

**logic diagram (positive logic)**

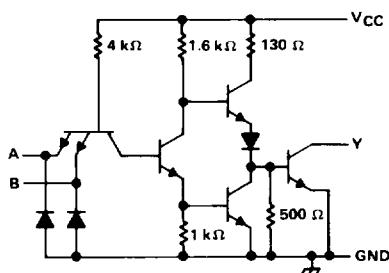


**FUNCTION TABLE  
(EACH DRIVER)**

A	B	Y
L	L	L (on state)
L	H	L (on state)
H	L	L (on state)
H	H	H (off state)

positive logic:  
 $Y = AB \text{ or } \overline{A+B}$

**schematic (each driver)**



Pin numbers shown are for D, JG, and P packages.

Resistor values shown are nominal.

**electrical characteristics over recommended operating free-air temperature range**

PARAMETER	TEST CONDITIONS‡	SN55451B			SN75451B			UNIT
		MIN	TYP§	MAX	MIN	TYP§	MAX	
V <sub>IK</sub> Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA	-1.2	-	-1.5	-1.2	-	-1.5	V
I <sub>OH</sub> High-level output current	V <sub>CC</sub> = MIN, V <sub>IH</sub> = MIN, V <sub>OH</sub> = 30 V	300			100			μA
V <sub>OL</sub> Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 100 mA	0.25	0.5		0.25	0.4		V
	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 300 mA	0.5	0.8		0.5	0.7		
I <sub>I</sub> Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V	1			1			mA
I <sub>IH</sub> High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.4 V	40			40			μA
I <sub>IL</sub> Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V	-1	-1.6		-1	-1.6		mA
I <sub>CCH</sub> Supply current, outputs high	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5 V	7	11		7	11		mA
I <sub>CCL</sub> Supply current, outputs low	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0	52	65		52	65		mA

‡For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

§All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

**switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C**

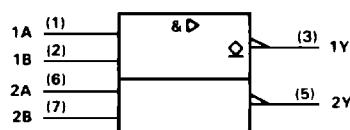
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> Propagation delay time, low-to-high-level output		18	25		ns
t <sub>PHL</sub> Propagation delay time, high-to-low-level output	I <sub>O</sub> ≈ 200 mA, C <sub>L</sub> = 15 pF, R <sub>L</sub> = 50 Ω, See Figure 1	18	25		ns
t <sub>TLH</sub> Transition time, low-to-high-level output		5	8		ns
t <sub>THL</sub> Transition time, high-to-low-level output		7	12		ns
V <sub>OH</sub> High-level output voltage after switching	SN55451B	V <sub>S</sub> = 20 V, I <sub>O</sub> ≈ 300 mA,		V <sub>S</sub> - 6.5	mV
	SN75451B	See Figure 2		V <sub>S</sub> - 6.5	

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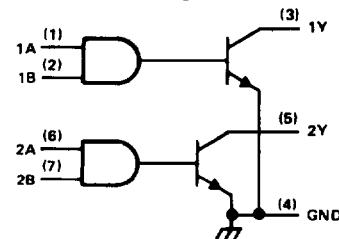
# SN55452B, SN75452B DUAL PERIPHERAL POSITIVE-NAND DRIVERS

logic symbol†



†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)

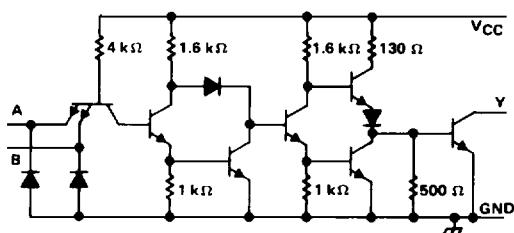


FUNCTION TABLE  
(EACH DRIVER)

A	B	Y
L	L	H (off state)
L	H	H (off state)
H	L	H (off state)
H	H	L (on state)

positive logic:  
 $Y = \overline{AB}$  or  $\overline{A} + \overline{B}$

schematic (each driver)



Pin numbers shown are for D, JG, and P packages.

Resistor values shown are nominal.

## electrical characteristics over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS‡	SN55452B			SN75452B			UNIT
		MIN	TYP§	MAX	MIN	TYP§	MAX	
V <sub>IK</sub> Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA	-1.2	-	-1.5	-1.2	-	-1.5	V
I <sub>OH</sub> High-level output current	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V V <sub>OH</sub> = 30 V	300			100			μA
V <sub>OL</sub> Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = MIN I <sub>OL</sub> = 100 mA	0.25	0.5	0.4	0.25	0.4	0.4	V
	V <sub>CC</sub> = MIN, V <sub>IH</sub> = MIN, I <sub>OL</sub> = 300 mA	0.5	0.8	0.7	0.5	0.7	0.7	
I <sub>I</sub> Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V	1			1			mA
I <sub>IH</sub> High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.4 V	40			40			μA
I <sub>IL</sub> Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V	-1.1	-	-1.6	-1.1	-	-1.6	mA
I <sub>CCH</sub> Supply current, outputs high	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0	11	14		11	14		mA
I <sub>CCL</sub> Supply current, outputs low	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5 V	56	71		56	71		mA

‡ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

§ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

## switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

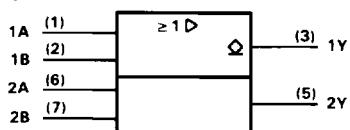
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> Propagation delay time, low-to-high-level output		26	35		ns
t <sub>PHL</sub> Propagation delay time, high-to-low-level output	I <sub>O</sub> = 200 mA, C <sub>L</sub> = 15 pF,	24	35		ns
t <sub>TLH</sub> Transition time, low-to-high-level output	R <sub>L</sub> = 50 Ω, See Figure 1	5	8		ns
t <sub>THL</sub> Transition time, high-to-low-level output		7	12		ns
V <sub>OH</sub> High-level output voltage after switching	V <sub>S</sub> = 20 V, I <sub>O</sub> ≈ 300 mA,	V <sub>S</sub> - 6.5			mV
	See Figure 2	V <sub>S</sub> - 6.5			

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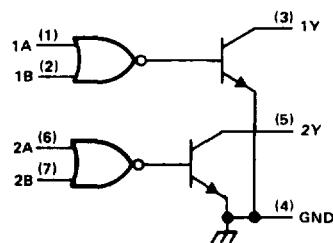
**SN55453B, SN75453B**  
**DUAL PERIPHERAL POSITIVE-OR DRIVERS**

logic symbol†



†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)

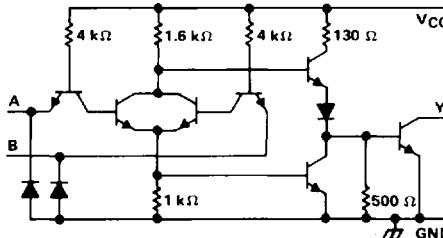


FUNCTION TABLE  
(EACH DRIVER)

A	B	Y
L	L	L (on state)
L	H	H (off state)
H	L	H (off state)
H	H	H (off state)

positive logic:  
 $Y = A + B \text{ or } \overline{AB}$

schematic (each driver)



Pin numbers shown are for D, JG, and P packages.

Resistor values shown are nominal.

electrical characteristics over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS‡	SN55453B			SN75453B			UNIT
		MIN	TYP§	MAX	MIN	TYP§	MAX	
V <sub>IK</sub> Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA	-1.2	-1.5		-1.2	-1.5		V
I <sub>OH</sub> High-level output current	V <sub>CC</sub> = MIN, V <sub>IH</sub> = MIN, V <sub>OH</sub> = 30 V		300			100		µA
V <sub>OL</sub> Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 100 mA	0.25	0.5		0.25	0.4		V
	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 300 mA	0.5	0.8		0.5	0.7		
I <sub>I</sub> Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V		1			1		mA
I <sub>IH</sub> High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.4 V		40			40		µA
I <sub>IL</sub> Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V	-1	-1.6		-1	-1.6		mA
I <sub>CCH</sub> Supply current, outputs high	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5 V	8	11		8	11		mA
I <sub>CCL</sub> Supply current, outputs low	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0	54	68		54	68		mA

‡For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

§All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

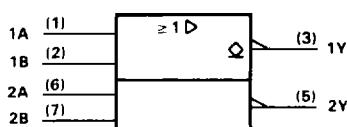
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> Propagation delay time, low-to-high-level output		18	25		ns
t <sub>PHL</sub> Propagation delay time, high-to-low-level output	I <sub>O</sub> = 200 mA, C <sub>L</sub> = 15 pF,	16	25		ns
t <sub>TLH</sub> Transition time, low-to-high-level output	R <sub>L</sub> = 50 Ω, See Figure 1	5	8		ns
t <sub>THL</sub> Transition time, high-to-low-level output		7	12		ns
V <sub>OH</sub> High-level output voltage after switching	V <sub>S</sub> = 20 V, I <sub>O</sub> = 300 mA,	V <sub>S</sub> - 6.5			mV
	See Figure 2	V <sub>S</sub> - 6.5			

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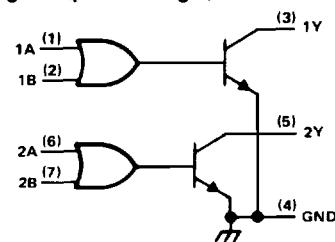
# SN55454B, SN75454B DUAL PERIPHERAL POSITIVE-NOR DRIVERS

logic symbol†



†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



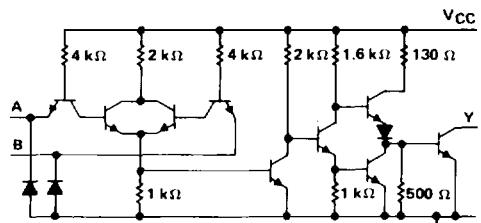
FUNCTION TABLE  
(EACH DRIVER)

A	B	Y
L	L	H (off state)
L	H	L (on state)
H	L	L (on state)
H	H	L (on state)

positive logic:

$$Y = \overline{A + B} \text{ or } \overline{AB}$$

schematic (each driver)



Pin numbers shown are for D, JG, and P packages.

Resistor values shown are nominal.

## electrical characteristics over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS‡	SN55454B			SN75454B			UNIT
		MIN.	TYP§	MAX.	MIN.	TYP§	MAX.	
V <sub>IK</sub> Input clamp voltage	V <sub>CC</sub> = MIN., I <sub>I</sub> = -12 mA	-	1.2	-1.5	-	1.2	-1.5	V
I <sub>OH</sub> High-level output current	V <sub>CC</sub> = MIN., V <sub>IL</sub> = 0.8 V V <sub>OH</sub> = 30 V	300			100			μA
V <sub>OL</sub> Low-level output voltage	V <sub>CC</sub> = MIN., V <sub>IH</sub> = MIN. I <sub>OL</sub> = 100 mA	0.25	0.5	-	0.25	0.4	-	V
	V <sub>CC</sub> = MIN., V <sub>IH</sub> = MIN., I <sub>OL</sub> = 300 mA	0.5	0.8	-	0.5	0.7	-	
I <sub>I</sub> Input current at maximum input voltage	V <sub>CC</sub> = MAX., V <sub>I</sub> = 5.5 V	-	1	-	1	-	1	mA
I <sub>IH</sub> High-level input current	V <sub>CC</sub> = MAX., V <sub>I</sub> = 2.4 V	-	40	-	40	-	40	μA
I <sub>IL</sub> Low-level input current	V <sub>CC</sub> = MAX., V <sub>I</sub> = 0.4 V	-	-1	-1.6	-	-1	-1.6	mA
I <sub>CCH</sub> Supply current, outputs high	V <sub>CC</sub> = MAX., V <sub>I</sub> = 0	13	17	-	13	17	-	mA
I <sub>CLL</sub> Supply current, outputs low	V <sub>CC</sub> = MAX., V <sub>I</sub> = 5 V	61	79	-	61	79	-	mA

‡For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

§All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

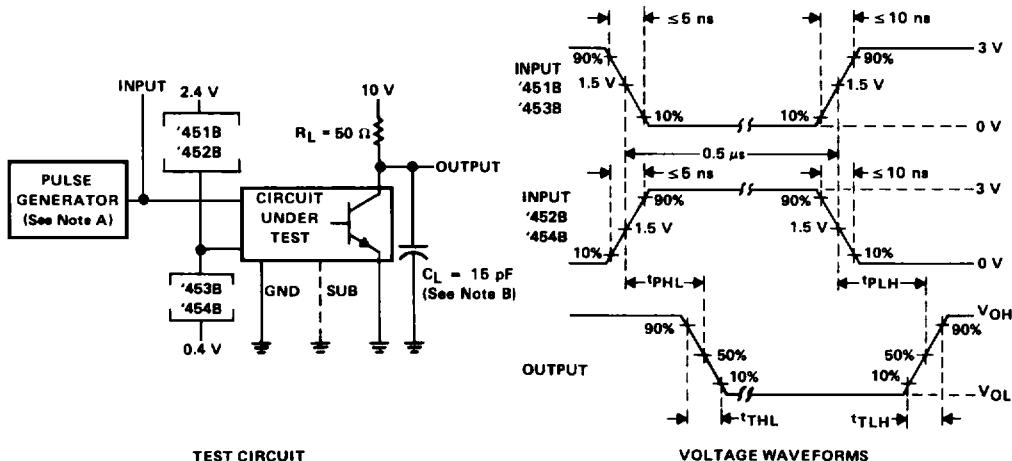
## switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> Propagation delay time, low-to-high-level output	-	27	35	-	ns
t <sub>PHL</sub> Propagation delay time, high-to-low-level output	-	24	35	-	ns
t <sub>TLH</sub> Transition time, low-to-high-level output	I <sub>O</sub> ≈ 200 mA, C <sub>L</sub> = 15 pF, R <sub>L</sub> = 50 Ω, See Figure 1	5	8	-	ns
t <sub>THL</sub> Transition time, high-to-low-level output	-	7	12	-	ns
V <sub>OH</sub> High-level output voltage after switching	SN55454B	V <sub>S</sub> = 20 V, I <sub>O</sub> ≈ 300 mA, See Figure 2	V <sub>S</sub> - 6.5	-	mV
	SN75454B	-	V <sub>S</sub> - 6.5	-	

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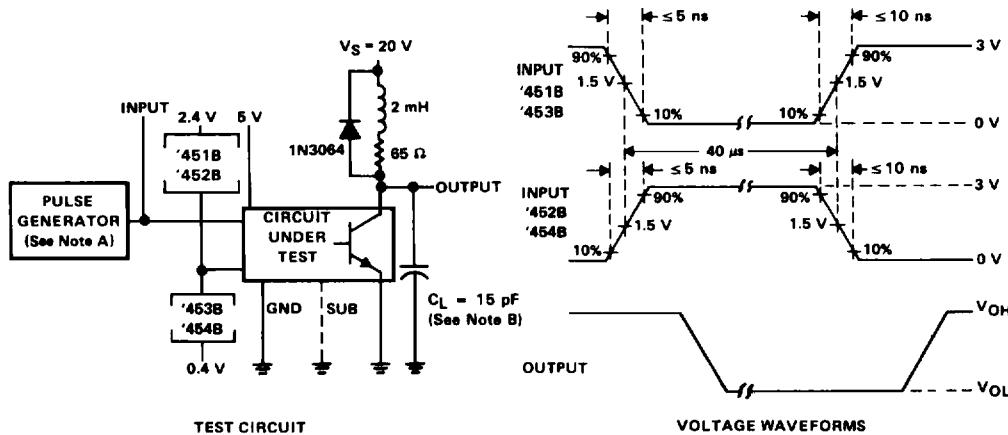
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**PARAMETER MEASUREMENT INFORMATION**



NOTES: A. The pulse generator has the following characteristics: PRR  $\leq$  1 MHz,  $Z_0 \approx 50 \Omega$ .  
B.  $C_L$  includes probe and jig capacitance.

**FIGURE 1. SWITCHING TIMES OF COMPLETE DRIVERS**



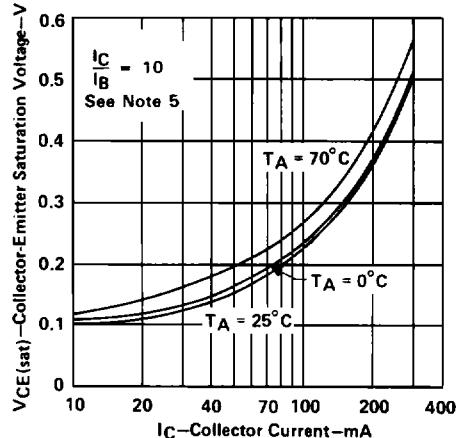
NOTES: A. The pulse generator has the following characteristics: PRR  $\leq$  12.5 kHz,  $Z_0 = 50 \Omega$ .  
B.  $C_L$  includes probe and jig capacitance.

**FIGURE 2. LATCH-UP TEST OF COMPLETE DRIVERS**

**SN55451B THRU SN55454B,  
SN75451B THRU SN75454B  
DUAL PERIPHERAL DRIVERS**

**TYPICAL CHARACTERISTICS**

TRANSISTOR  
COLLECTOR-EMITTER SATURATION VOLTAGE  
vs  
COLLECTOR CURRENT



NOTE 5: These parameters must be measured using pulse techniques,  $t_W = 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .

**FIGURE 3**

**TEXAS  
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